•	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/602,412	KNOWLES ET AL.	
Examiner	Art Unit	
David E. Bochna	3679	

	SEAR	CHED	
Class	Subclass	Date	Examiner
285	242	6/22/2005	DB
	245		
	252		
	254		
	255	"	
	259		
	261		

INT	ERFERENC	E SEARCH	IED
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARC		()
	DATE	EXMR
,		
		-
		į